

**Notice of References Cited**

Application/Control No.

10/664,436

Applicant(s)/Patent Under  
Reexamination  
FUJII ET AL.

Examiner

PAUL S. HYUN

Art Unit

1797

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0155010 A1	10-2002	Karp et al.	417/413.2
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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